Signetics

74174, LS174, S174
Flip-Flops

Hex D Flip-Flops
Product Specification

Logic Products

FEATURES

- **Six edge-triggered D-type flip-flops**
- **Three speed-power ranges available**
- **Buffered common clock**
- **Buffered, asynchronous Master Reset**

DESCRIPTION

The '174 has six edge-triggered D-type flip-flops with individual D inputs and Q outputs. The common buffered Clock (CP) and Master Reset ($\overline{MR}$) inputs load and reset (clear) all flip-flops simultaneously.

The register is fully edge triggered. The state of each D input, one set-up time before the LOW-to-HIGH clock transition, is transferred to the corresponding flip-flop's Q output.

All outputs will be forced LOW independently of Clock or Data inputs by a LOW voltage level on the $\overline{MR}$ input. The device is useful for applications where the true output only is required and the Clock and Master Reset are common to all storage elements.

TYPE	TYPICAL f_{MAX}	TYPICAL SUPPLY CURRENT (TOTAL)
74174	35MHz	45mA
74LS174	40MHz	16mA
74S174	110MHz	90mA

ORDERING CODE

PACKAGES	COMMERCIAL RANGE V_{CC} = 5V ±5%; T_A = 0°C to +70°C
Plastic DIP	N74174N, N74LS174N, N74S174N
Plastic SO-16	N74LS174D, N74S174D

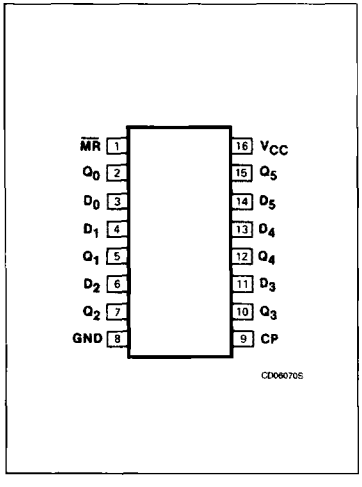
NOTE:
For information regarding devices processed to Military Specifications, see the Signetics Military Products Data Manual.

INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

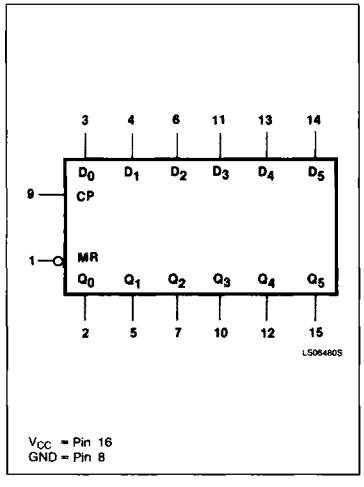
PINS	DESCRIPTION	74	74S	74LS
All	Inputs	1ul	1Sul	1LSul
$Q_0 - Q_5$	Outputs	10ul	10Sul	10LSul

NOTE:
Where a 74 unit load (ul) is understood to be 40μA I_{IH} and −1.6mA I_{IL}, a 74S unit load (Sul) is 50μA I_{IH} and −2.0mA I_{IL}, and 74LS unit load (LSul) is 20μA I_{IH} and −0.4mA I_{IL}.

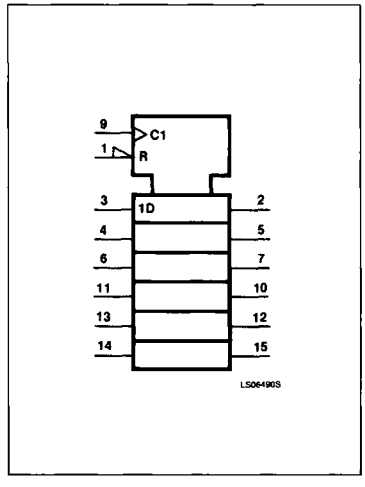
PIN CONFIGURATION



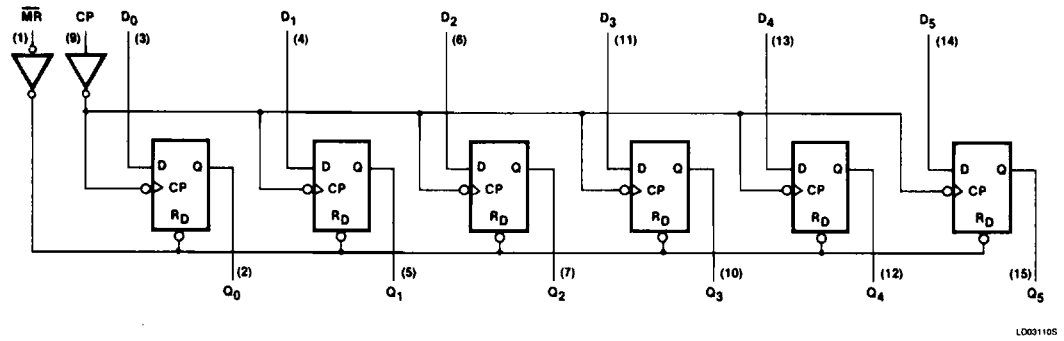
LOGIC SYMBOL



LOGIC SYMBOL (IEEE/IEC)



LOGIC DIAGRAM



V_{CC} = Pin 16
GND = Pin 8
( ) = Pin Numbers

FUNCTION TABLE

OPERATING MODE	INPUTS			OUTPUTS
	$\overline{MR}$	CP	D_n	Q_n
Reset (clear)	L	X	X	L
Load "1"	H	↑	h	H
Load "0"	H	↑	l	L

H = HIGH voltage level steady state
h = HIGH voltage level one set-up time prior to the LOW-to-HIGH clock transition.
L = LOW voltage level steady state.
l = LOW voltage level one set-up time prior to the LOW-to-HIGH clock transition.
X = Don't care.
↑ = LOW-to-HIGH clock transition.

ABSOLUTE MAXIMUM RATINGS (Over operating free-air temperature range unless otherwise noted.)

	PARAMETER	74	74LS	74S	UNIT
V_{CC}	Supply voltage	7.0	7.0	7.0	V
V_{IN}	Input voltage	−0.5 to +5.5	−0.5 to +7.0	−0.5 to +5.5	V
I_{IN}	Input current	−30 to +5	−30 to +1	−30 to +5	mA
V_{OUT}	Voltage applied to output in HIGH output state	−0.5 to +V_{CC}	−0.5 to +V_{CC}	−0.5 to +V_{CC}	V
T_A	Operating free-air temperature range	0 to 70			°C

RECOMMENDED OPERATING CONDITIONS

	PARAMETER	74			74LS			74S			UNIT
		Min	Nom	Max	Min	Nom	Max	Min	Nom	Max	
V_{CC}	Supply voltage	4.75	5.0	5.25	4.75	5.0	5.25	4.75	5.0	5.25	V
V_{IH}	HIGH-level input voltage	2.0			2.0			2.0			V
V_{IL}	LOW-level input voltage			+0.8			+0.8			+0.8	V
I_{IK}	Input clamp current			−12			−18			−18	mA
I_{OH}	HIGH-level output current			−800			−400			−1000	μA
I_{OL}	LOW-level output current			16			8			20	mA
T_A	Operating free-air temperature	0		70	0		70	0		70	°C

DC ELECTRICAL CHARACTERISTICS (Over recommended operating free-air temperature range unless otherwise noted.)

PARAMETER		TEST CONDITIONS[1]		74174			74LS174			74S174			UNIT
				Min	Typ[2]	Max	Min	Typ[2]	Max	Min	Typ[2]	Max	
V_{OH}	HIGH-level output voltage	V_{CC} = MIN, V_{IH} = MIN, V_{IL} = MAX, I_{OH} = MAX		2.4	3.4		2.7	3.4		2.7	3.4		V
V_{OL}	LOW-level output voltage	V_{CC} = MIN, V_{IH} = MIN, V_{IL} = MAX	I_{OL} = MAX		0.2	0.4		0.35	0.5			0.5	V
			I_{OL} = 4mA (74LS)					0.25	0.4				V
V_{IK}	Input clamp voltage	V_{CC} = MIN, I_I = I_{IK}				−1.5			−1.5			−1.2	V
I_I	Input current at maximum input voltage	V_{CC} = MAX	V_I = 5.5V			1.0						1.0	mA
			V_I = 7.0V						0.1				mA
I_{IH}	HIGH-level input current	V_{CC} = MAX	V_I = 2.4V			40							μA
			V_I = 2.7V						20			50	μA
I_{IL}	LOW-level input current	V_{CC} = MAX	V_I = 0.4V			−1.6			−0.4				mA
			V_I = 0.5V									−2.0	mA
I_{OS}	Short-circuit output current[3]	V_{CC} = MAX		−18		−57	−20		−100	−40		−100	mA
I_{CC}	Supply current[4] (total)	V_{CC} = MAX			45	65		16	26		90	144	mA

NOTES:

1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.
2. All typical values are at V_{CC} = 5V, T_A = 25°C.
3. I_{OS} is tested with V_{OUT} = +0.5V and V_{CC} = V_{CC} MAX + 0.5V. Not more than one output should be shorted at a time and duration of the short circuit should not exceed one second.
4. I_{CC} is measured after a momentary ground, then 4.5V is applied to Clock, with 4.5V applied to all Data and $\overline{MR}$ inputs and all outputs open.

AC ELECTRICAL CHARACTERISTICS T_A = 25°C, V_{CC} = 5.0V

PARAMETER		TEST CONDITIONS	74		74LS		74S		UNIT
			C_L = 15pF, R_L = 400Ω		C_L = 15pF, R_L = 2kΩ		C_L = 15pF, R_L = 280Ω		
			Min	Max	Min	Max	Min	Max	
f_{MAX}	Maximum clock frequency	Waveform 1	25		30		75		MHz
t_{PLH} t_{PHL}	Propagation delay Clock to output	Waveform 1		30 35		30 30		13 17	ns
t_{PHL}	Propagation $\overline{MR}$ delay to output	Waveform 3		35		35		22	ns

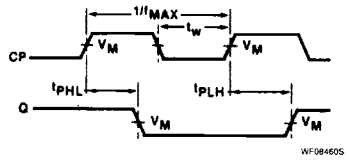
NOTE:

Per industry convention, f_{MAX} is the worst case value of the maximum device operating frequency with no constraints on t_r, t_f, pulse width or duty cycle.

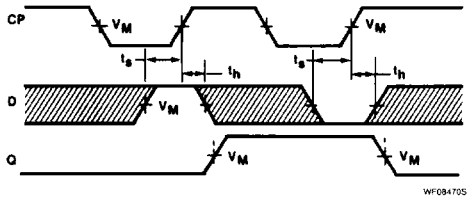
AC SET-UP REQUIREMENTS $T_A = 25°C$, $V_{CC} = 5.0V$

PARAMETER		TEST CONDITIONS	74		74LS		74S		UNIT
			Min	Max	Min	Max	Min	Max	
$t_W(L)$	Clock pulse width (LOW)	Waveform 1	20		20		7.0		ns
t_W	Master Reset pulse width	Waveform 3	20		20		10		ns
t_s	Set-up time, data to CP	Waveform 2	20		20		5.0		ns
t_h	Hold time, data to CP	Waveform 2	5		5		3.0		ns
t_{rec}	Recovery time, $\overline{MR}$ to CP	Waveform 3	25		25		5.0		ns

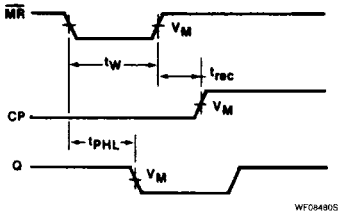
AC WAVEFORMS



Waveform 1. Clock To Output Delays And Clock Pulse Width



Waveform 2. Data Set-up And Hold Times

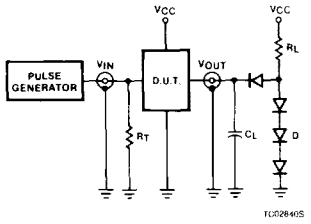


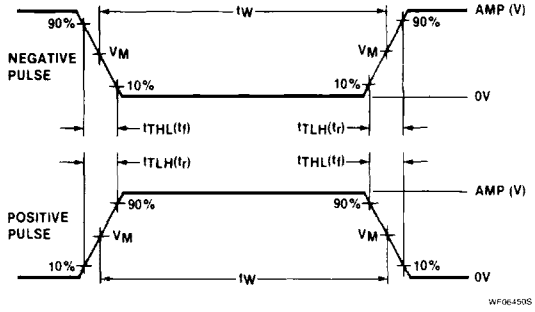
For all waveforms, $V_M = 1.5V$ for 74 and 74S; $V_M = 1.3V$ for 74LS.
The shaded areas indicate when the input is permitted to change for predictable output performance

Waveform 3. Master Reset To Output Delay, Master Reset Pulse Width, And Master Reset Recovery Time

5

TEST CIRCUITS AND WAVEFORMS





V_M = 1.3V for 74LS; V_M = 1.5V for all other TTL families.

Test Circuit For 74 Totem-Pole Outputs

DEFINITIONS

R_L = Load resistor to V_{CC}; see AC CHARACTERISTICS for value.

C_L = Load capacitance includes jig and probe capacitance; see AC CHARACTERISTICS for value.

R_T = Termination resistance should be equal to Z_{OUT} of Pulse Generators.

D = Diodes are 1N916, 1N3064, or equivalent.

t_{TLH}, t_{THL} Values should be less than or equal to the table entries.

Input Pulse Definition

FAMILY	INPUT PULSE REQUIREMENTS				
	Amplitude	Rep. Rate	Pulse Width	t_{TLH}	t_{THL}
74	3.0V	1MHz	500ns	7ns	7ns
74LS	3.0V	1MHz	500ns	15ns	6ns
74S	3.0V	1MHz	500ns	2.5ns	2.5ns